

Enhancement Mode P-Channel Power MOSFET

SOT23/PMOS/-30V/ \pm 12V/-0.9V/-4.8A/39m Ω

Rev1.5





-30V,39mΩ, -4.8A, P-Channel MOSFET

1.Features

- Advanced Trench Technology
- ◆ Surface mount package

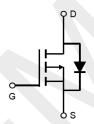
2.Applications

- Power Management
- Load Switching



Pin Description





Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP3401ASS	3401	SOT23	3,000	180,000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V _{DSS}	-30	V
Gate to Source Voltage	V _{GSS}	±12	V
Drain Current (DC)	lσ	-4.8	А
Drain Current (Pulse), PW≤300μs	I _{DP}	-17	А
Total Dissipation	P _D	1.5	W
Junction Temperature	Tj	150	°C
Storage Temperature	T _{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Ambient	Reja	83	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.



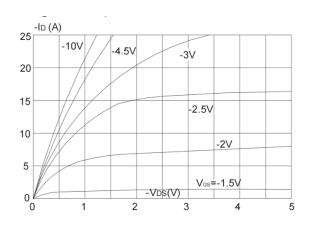
6.Electrical Characteristics at Ta=25°C (Note 3)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = -250 \mu A$, $V_{GS} = 0 V$	-30	-33		V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} = -30V, V _{GS} = 0V			-1	μΑ
Gate to Source Leakage Current	I _{GSS}	$V_{GS} = \pm 12V, V_{DS} = 0V$			±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V _{DS} =V _{GS} , I _{DS} =-250μA	-0.6	-0.9	-1.3	V
		I _D =-4A, V _{GS} =-10V		39	45	mΩ
Static Drain to Source On-State Resistance	R _{DS(on)}	I _D =-3A, V _{GS} =-4.5V		43	55	mΩ
registarioc		I _D =-1A, V _{GS} = -2.5V		54	75	mΩ
Input Capacitance	Ciss	V _{GS} =0V,		770		pF
Output Capacitance	Coss	V _{DS} =-15V,		74		pF
Reverse Transfer Capacitance	C _{rss}	Frequency=1.0MHz		42	,	pF
Turn-ON Delay Time	t _{d(on)}			7		ns
Rise Time	tr	V _{DD} =-15V, I _D =-1A,		4		ns
Turn-OFF Delay Time	$t_{d(off)}$	$R_G = 2.5\Omega$, $V_{GS} = -10V$		27		ns
Fall Time	t _f			13		ns
	Qg	V _{DS} = -15V,		16		nC
Total Gate Charge	Qgs	V _{GS} = -10V,		2		nC
	Q_{gd}	I _D = -4.2A		1.8		nC
Diode Forward Voltage	V _{FSD}	I _S = -4A, V _{GS} = 0	-0.4	-0.9	-1.2	V

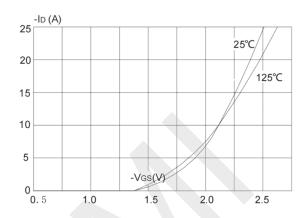
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.



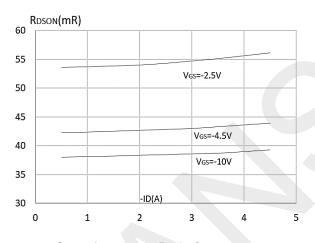
7. Typical Electrical and Thermal Characteristics



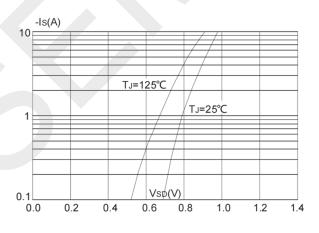
Output Characteristics



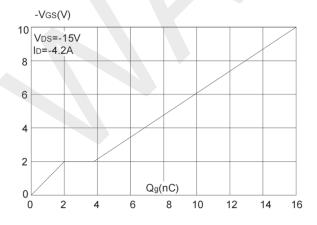
Typical Transfer Characteristics



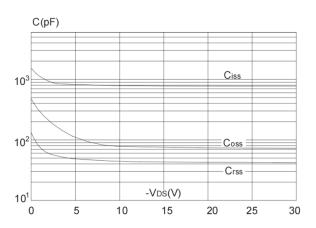
On-resistance vs. Drain Current



Body Diode Characteristics

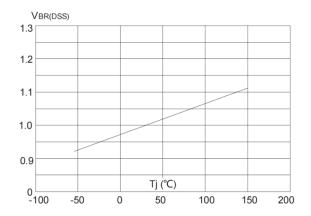


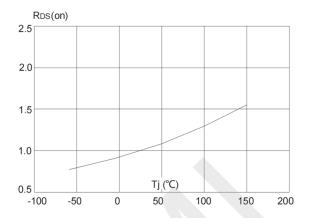
Gate Charge Characteristics



Capacitance Characteristics

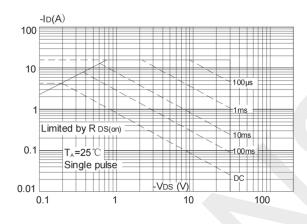


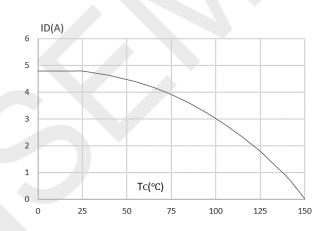




Normalized Breakdown Voltage vs. Junction Temperature

Normalized on Resistance vs.Junction Temperature

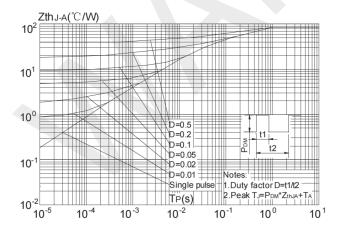




Maximum Safe Operating Area

Maximum Continuous Drain Current vs.

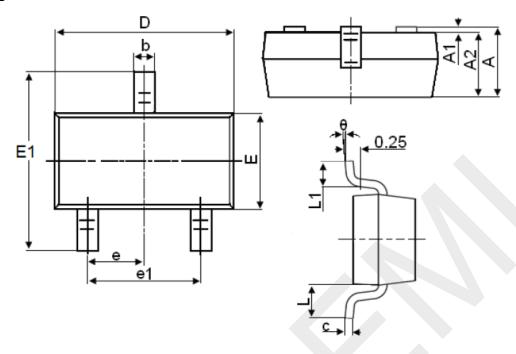
Ambient Temperature



Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



8.Package Dimensions



	Dimensions in Millimeters				
Symbol	MIN.	TYP.	MAX.		
А	0.900		1.150		
A1	0.000		0.100		
A2	0.900		1.050		
b	0.300		0.500		
С	0.080		0.150		
D	2.800		3.000		
E	1.200		1.400		
E1	2.250		2.550		
е		0.950			
e1	1.800		2.000		
L		0.550			
L1	0.300		0.500		
θ	0°		8°		



9.Important Notice

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